

Application/Control No.	Applicant(s)/Patent under Reexamination
09/891,017	IKEDA ET AL.
Examiner	Art Unit
LUONG T. NGUYEN	2612

	SEARCHED				
Class	Subclass	Date	Examiner		
	•				
	_				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	l				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT; US-PGPUB; JPO; EPO; DERWENT) see search history printout	2/3/2006	LN		